

<b>Notice of References Cited</b>	Application/Control No. 10/626,762		Applicant(s)/Patent Under Reexamination WALKER ET AL.	
	Examiner Leigh Marie Garbowski		Art Unit 2825	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,922,819	07-2005	Visweswariah, Chandramouli	716/2
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	ANTREICH et al., "An Interactive Optimization Technique for the Nominal Design of ICS," IEEE Trans. on Circuits and Systems, Vol. CAS-31, No. 2, February 1984, pages 203-212.
	V	CHEN, "A Least pth Optimization Algorithm Without Calculating Derivatives," IEEE Trans. on Circuits and Systems, Vol. CAS-28, No. 4, April 1981, pages 331-337.
	W	DOGANIS et al., "General Optimization and Extraction of IC Device Model Parameters," IEEE Trans. on Electron Devices, Vol. ED-30, No. 9, September 1983, pages 1219-1228.
	X	GONZAGA et al., "An Improved Algorithm for Optimization Problems with Functional Inequality Constraints," IEEE Trans. on Automatic Control, Vol. AC-25, No. 1, February 1980, pages 49-54.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	Examiner Leigh Marie Garbowski	Art Unit 2825	Page 2 of 2

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	A	US-			
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	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	TRAHAN et al., "A Derivative-Free Algorithm for a Class of Infinitely Constrained Problems," IEEE Trans. on Automatic Control, Vol. AC-25, No. 1, February 1980, pages 54-61.
	V	
	W	
	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.